Notice of References Cited Application/Control No. 10/749,638 Examiner Kevin Gutierrez Applicant(s)/Patent Under Reexamination HAKEY ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,907,021	03-1990	Yabu, Shuichi	353/101
*	В	US-2002/0080226 A1	06-2002	Johnson, Bruce K.	347/233
*	С	US-6,191,889 B1	02-2001	Maruyama, Koichi	359/566
*	D	US-5,825,043 A	10-1998	Suwa, Kyoichi	250/548
*	Ε	US-4,978,212	12-1990	Hazard, Edwin A.	351/212
*	F	US-2002/0044260 A1	04-2002	Takahashi et al.	353/31
*	G	US-2002/0019136	02-2002	Suzuki, Hiroyuki	438/694
*	Н	US-5,900,354 A	05-1999	Batchelder, John Samuel	430/395
*	ı	US-2005/0100745 A1	05-2005	Lin et al.	428/446
*	J	US-2004/0109237 A1	06-2004	Epple et al.	359/649
	к	US-			
	L	US-			
	М	US-			·

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V							
	w							
	x							

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.